

**Search Notes**

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VAN T. PHAM

Applicant(s)/Patent under  
Reexamination

CHEN ET AL.

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East (US-PGPUB; USPAT; USOCR;EPO;JPO;DERWENT;IBM_T DB)  369 and 369/53.31, 47. (text search only see search history printout).	2/14/2007	VP